

Search Notes

Application/Control No.

10/685,210

Examiner

Jay M. Patidar

Applicant(s)/Patent under
Reexamination

LEI ET AL.

Art Unit

2862

SEARCHED

Class	Subclass	Date	Examiner
451	8	4/3/2006	JP
356	614		
324	226		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
324	230	4/3/2006	JP
	226		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR